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March 2016

FDC30N20DZ

Dual N-Channel PowerTrench® MOSFET 30 V, 4.6 A, 31 m Ω

Features

- Max $r_{DS(on)} = 31 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 4.6 \text{ A}$
- Max $r_{DS(on)}$ = 38 m Ω at V_{GS} = 4.5 V, I_D = 4.2 A
- High Performance Trench® Technology for Extremely Low r_{DS(on)}
- Fast Switching Speed
- 100% UIL Tested
- Typical CDM ESD protection level > 2.0 kV (Note 5)
- RoHS Compliant

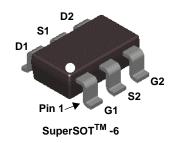


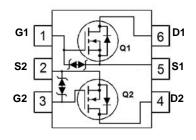
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process. This process has been optimized for $r_{DS(on)}$, switching performance and ruggedness.

Applications

- Load Switch
- Synchronous Rectifier





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted.

Symbol	Parameter		Ratings	Units
V _{DS}	Drain to Source Voltage		30	V
V _{GS}	Gate to Source Voltage		±20	V
	Drain Current -Continuous	(Note 1a)	4.6	Α
'D	-Pulsed	(Note 4)	30	Α
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	3	mJ
В	Power Dissipation	(Note 1a)	0.96	W
P_{D}	Power Dissipation	(Note 1b)	0.69	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	130	°C/W
$R_{\theta,JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	180	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
.30N20	FDC30N20DZ	SSOT-6	7 "	8 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	cteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to 25 °C		22		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1	1.7	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to 25 °C		-4		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 4.6 A		23	31	
		$V_{GS} = 4.5 \text{ V}, I_D = 4.2 \text{ A}$		27	38	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 4.6 \text{ A}, T_J = 125 ^{\circ}\text{C}$		31	42	1
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 4.6 A		23		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45 V V 0 V		356	535	pF
C _{oss}	Output Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ $V_{DS} = 16 \text{ Hz}$		110	165	pF
C _{rss}	Reverse Transfer Capacitance	-1 - 11VII 12		18	30	pF
R_g	Gate Resistance		0.1	3.5	7.0	Ω

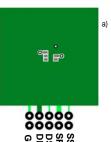
Switching Characteristics

	•				
t _{d(on)}	Turn-On Delay Time		6	12	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 4.6 A,	2	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	13	21	ns
t _f	Fall Time		2	10	ns
$Q_{g(TOT)}$	Total Gate Charge	V _{GS} = 0 V to 10 V	5.6	7.9	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} V_{DD} = 15 \text{ V},$	2.7	3.8	nC
Q _{gs}	Gate to Source Charge	I _D = 4.6 A	0.9		nC
Q _{ad}	Gate to Drain "Miller" Charge		0.8		nC

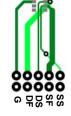
Drain-Source Diode Characteristics

V_{SD}	Source-Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 4.6 A$ (Note 2)	0.85	1.2	V
t _{rr}	Reverse Recovery Time	1 4 6 A di/dt 400 A/va	10	20	ns
Q_{rr}	Reverse Recovery Charge	$I_F = 4.6 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$	2	10	nC

^{1.} $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 130 °C/W when mounted on a 1 in 2 pad of 2 oz copper



b) 180 °C/W when mounted on a $minimum\,pad\,of\,2\,oz\,copper$

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. E_{AS} of 3 mJ starting T_J = 25 °C; N-ch: L = 0.1 mH, I_{AS} = 8 A, V_{DD} = 27 V, V_{GS} = 10 V. 4. Pulse Id measured at td <= 250 μ s, refer to SOA graph for more details.
- 5. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted.

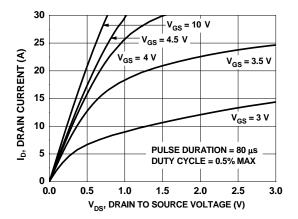


Figure 1. On-Region Characteristics

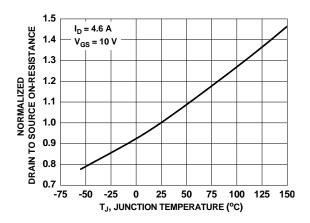


Figure 3. Normalized On-Resistance vs. Junction Temperature

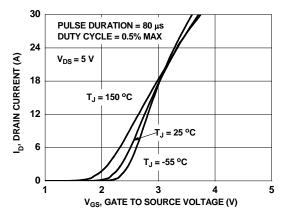


Figure 5. Transfer Characteristics

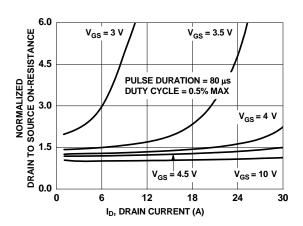


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

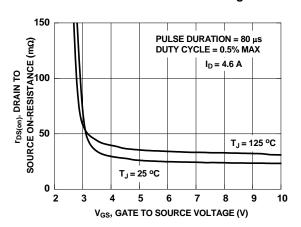


Figure 4. On-Resistance vs. Gate to Source Voltage

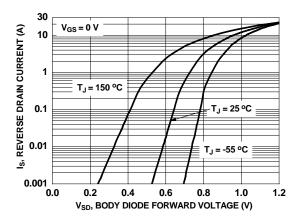


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted.

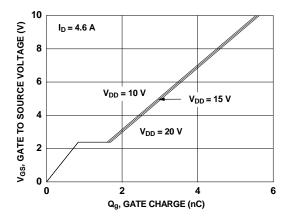


Figure 7. Gate Charge Characteristics

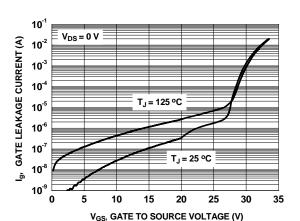


Figure 9. Gate Leakage Current vs Gate to Source Voltage

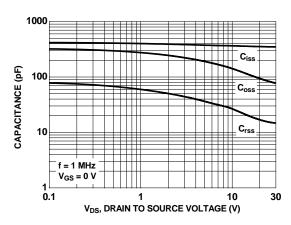


Figure 8. Capacitance vs. Drain to Source Voltage

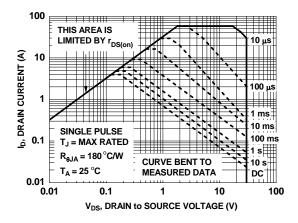


Figure 10. Forward Bias Safe Operating Area

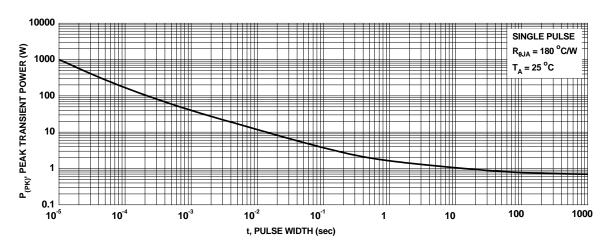


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted.

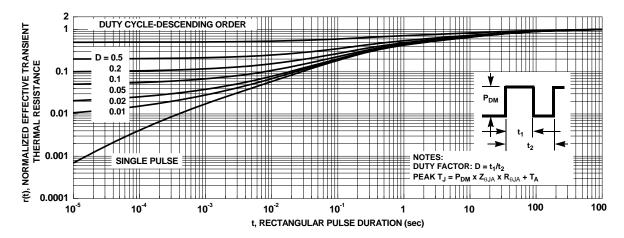
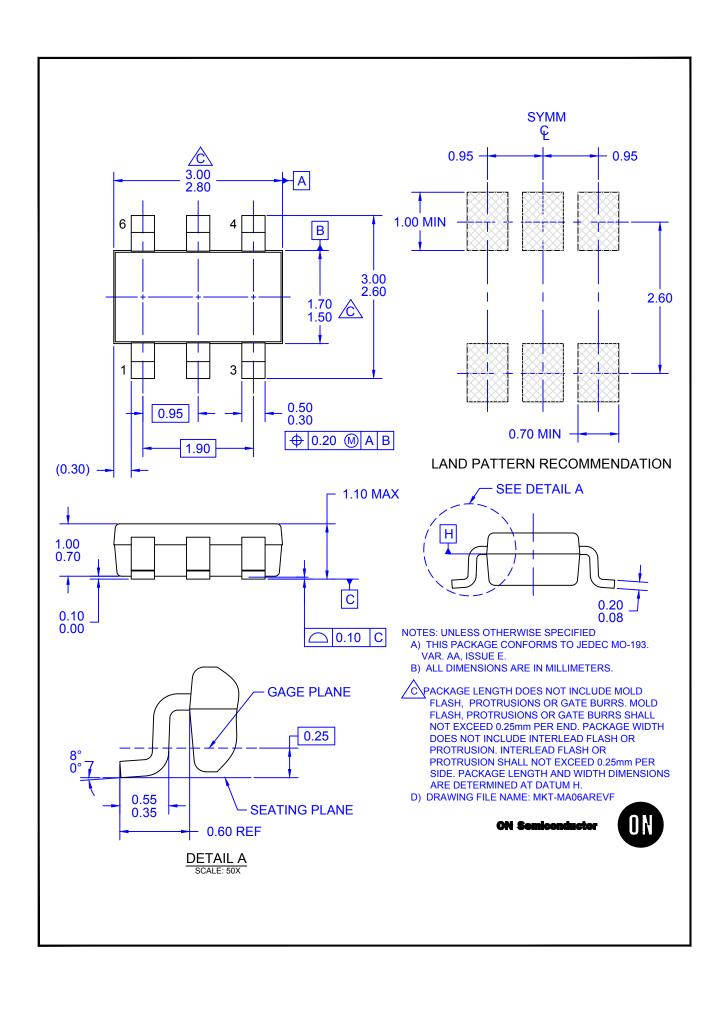


Figure 12. Junction to Ambient Transient Thermal Response Curve



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